# CE EMC TEST REPORT

for

**1U Rackmount Network Appliance** 

MODEL: xFWS-7520x (x - Where x may be any combination of alphanumeric characters or "-"or blank.)

Test Report Number: T160422D10-E

Issued to:

## AAEON Technology Inc.

5F, No.135, Lane 235, Pao Chiao Rd, Hsin-Tien Dist., New Taipei City, Taiwan, R.O.C

Issued by:

### **Compliance Certification Services Inc.**

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Issued Date: May 18, 2016



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## **Revision History**

Rev.	lssue Date	Revisions	Effect Page	Revised By
00	May 18, 2016	Initial Issue	ALL	Panny Chou

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# **1 TEST CERTIFICATION**

Product:	1U Rackmount Network Appliance					
Model:	xFWS-7520x (x - Where x may be any combination of alphanumeric characters or "-"or blank.)					
Brand:	AAEON					
Applicant:	<b>AAEON Technology Inc.</b> 5F, No.135, Lane 235, Pao Chiao Rd, Hsin-Tien Dist., New Taipei City, Taiwan, R.O.C					
Manufacturer:	<b>AAEON Technology Inc.</b> 5F, No.135, Lane 235, Pao Chiao Rd, Hsin-Tien Dist., New Taipei City, Taiwan, R.O.C					
Tested:	April 23, 2016 ~ May 16, 2016					
	Die   EN 55011: 2009 + A1: 2010 (Group 1, Class A)   EN 61000-6-1: 2007     IS:   EN 61000-3-2: 2014   IEC 61000-4-2: 2008     EN 61000-3-3: 2013   IEC 61000-4-3: 2006 + A1: 2007 + A2: 2010     IEC 61000-4-4: 2012   IEC 61000-4-5: 2014     IEC 61000-4-6: 2013   IEC 61000-4-8: 2009     IEC 61000-4-11: 2004   IEC 61000-4-11: 2004					

#### **Deviation from Applicable Standard**

None

The above equipment was tested by Compliance Certification Services Inc. for compliance with the requirements of technical standards specified above under the EMC Directive 2014/30/EU. The results of testing in this report apply only to the product/system, which was tested. Other similar equipment will not necessarily produce the same results due to production tolerance and measurement uncertainties.

Approved by:

Sam Hu Assistant Manager Reviewed by:

Eva Fan / Supervisor of report document dept.

# 2 TEST RESULT SUMMARY

EMISSION						
Standard	Item	Result	Remarks			
EN 55011: 2009 + A1: 2010	Conducted	PASS	Meet Class A limit			
(Group 1, Class A)	Radiated	PASS	Meet Class A limit			
EN 61000-3-2: 2014	Harmonic current emissions	PASS	Meet Class A limit			
EN 61000-3-3: 2013	Voltage fluctuations & flicker	PASS	Meets the requirements			

IMMUNITY [ EN61000-6-1: 2007 ]					
Standard	Item	Result	Remarks		
IEC 61000-4-2: 2008	ESD	PASS	Meets the requirements of Performance Criterion A		
IEC 61000-4-3: 2006 + A1: 2007 + A2: 2010	RS	PASS	Meets the requirements of Performance Criterion A		
IEC 61000-4-4: 2012	EFT	PASS	Meets the requirements of Performance Criterion A		
IEC 61000-4-5: 2014	Surge	PASS	Meets the requirements of Performance Criterion A		
IEC 61000-4-6: 2013	CS	PASS	Meets the requirements of Performance Criterion A		
IEC 61000-4-8: 2009	PFMF	PASS	Meets the requirements of Performance Criterion A		
IEC 61000-4-11: 2004	Voltage dips & voltage variations	PASS	Meets the requirements of Voltage Dips: 1) 0% residual Performance Criterion A 2) 70% residual Performance Criterion A Voltage Interruptions: 1) 0% residual Performance Criterion C		

**Note:** 1. The statements of test result on the above are decided by the request of test standard only; the measurement uncertainties are not factored into this compliance determination.

2. The information of measurement uncertainty is available upon the customer's request.

# **3 EUT DESCRIPTION**

Product	1U Rackmount Network Appliance			
Brand Name	AAEON			
Model	xFWS-7520x (x - Where x may be any combination of alphanumeric characters or "-"or blank.)			
Applicant	AAEON Technology Inc.			
Housing material	Metal case			
Identify Number	T160422D10			
Received Date	April 22, 2016			
EUT Power Rating	100-240VAC			
AC Power During Test	230VAC / 50Hz			

#### **Model Differences**

Model	Difference	Tested (Check)		
FWS-7520W3-H25-A10-000	-7520W3-H25-A10-000 Original			
	1. For marketing purpose only			
xFWS-7520x	2. x - Where x may be any combination of			
	alphanumeric characters or "-"or blank.			

#### I/O PORT

I/O PORT TYPES	Q'TY	TESTED WITH
1. VGA Port	1	1
2. USB Port	2	2
3. LAN Port	9	9
4. IPMI Port	1	1
5. Console Port	1	1
6. Fiber Port	8	8

Note: Client consigns only one model sample to test (Model Number: FWS-7520W3-H25-A10-000).

# 4 TEST METHODOLOGY

## 4.1. DECISION OF FINAL TEST MODE

The EUT was tested together with the below additional components, and a configuration, which produced the worst emission levels, was selected and recorded in this report.

The test configuration/ mode is as the following:

#### **Conduction Mode:**

No.	Power Supply	Operate State		
1	FSP / FSP180-50LG	VGA Mode	1920X1080, VF=60Hz	
2	ETASIS / EFAP-S250	VGA Mode	1920X1080, VF=60Hz	

#### **Radiation Mode:**

No.	Power Supply	Operate State		
1	FSP / FSP180-50LG	VGAWODE	1920X1080, VF=60Hz	
•			1920X1080, VF=60Hz / 1-6GHz	
2	ETASIS / EFAP-S250	VGA Mode	1920X1080, VF=60Hz	

Worst: Conduction: Mode 2

Radiation: Mode 1

## 4.2. EUT SYSTEM OPERATION

- 1. All peripherals connect EUT.
- Press the start menu, select executive and type ping 192.168.1.2 –t (EUT), ping 192.168.2.2 –t (EUT), ping 192.168.3.2 –t (EUT), ping 192.168.4.2 –t (EUT), ping 192.168.5.2 –t (EUT), ping 192.168.6.2 –t (EUT), ping 192.168.7.2 –t (EUT), ping 192.168.8.2 –t (EUT), ping 192.168.9.2 –t (EUT), ping 192.168.10.2 –t (EUT), ping 192.168.1.1 –t (Server PC), ping 192.168.2.1 –t (Server PC), ping 192.168.3.1 –t (Server PC), ping 192.168.4.1 –t (Server PC), ping 192.168.5.1 –t (Server PC), ping 192.168.6.1 –t (Server PC), ping 192.168.7.1 –t (Server PC), ping 192.168.8.1 –t (Server PC), ping 192.168.9.1 –t (Server PC), ping 192.168.10.1 –t (Server PC).

**Note:** Test program is self-repeating throughout the test.

# 5 SETUP OF EQUIPMENT UNDER TEST

## 5.1. DESCRIPTION OF SUPPORT UNITS

The EUT has been tested as an independent unit together with other necessary accessories or support units. The following support units or accessories were used to form a representative test configuration during the tests.

### **EUT Devices:**

No.	Equipment	Model No.	Brand Name	
1	CPU (IntelR XeonR Processor / 2.0GHz)	D-1548	Intel	
2	Memory (128GB)	M88DDR4RCD01	Micron	
3	Power Supply	FSP180-50LG	FSP	
Ŭ		EFAP-S250	ETASIS	
4	HDD (500GB)	MQ01ABF050	Toshiba	

#### **Peripherals Devices:**

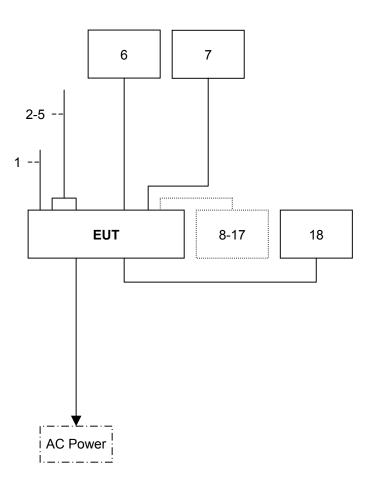
No.	Equipment	Model No.	Serial No.	FCC ID / BSMI ID	Brand Name	Data Cable	Power Cord
1	Console Cable	N/A	N/A	N/A	N/A	Shielded, 1.8m	N/A
2-5	Fiber Loop	N/A	N/A	N/A	N/A	Shielded, 2.5m	N/A
6	USB Mouse	M-U0026	810-002181	DOC BSMI: T41126	Logitech	Shielded, 1.8m	N/A
7	USB Keyboard	SK-8115	N/A	DOC BSMI: T3A002	DELL	Shielded, 1.8m	N/A
8-15	Server PC	T3500	N/A	BSMI ID: R33002	DELL	Unshielded, 20m	Unshielded, 1.8m
16-17	Server PC	T3610	N/A	BSMI ID: R33002	DELL	Unshielded, 20m	Unshielded, 1.8m
18	Monitor	P2314Ht	N/A	DOC BSMI: R33002	DELL	Shielded, 1.8m with two cores	Unshielded, 1.8m

#### Note:

1) All the equipment/cables were placed in the worst-case configuration to maximize the emission during the test.

2) Grounding was established in accordance with the manufacturer's requirements and conditions for the intended use.

## **5.2. CONFIGURATION OF SYSTEM UNDER TEST**



# 6 FACILITIES AND ACCREDITATIONS

## 6.1. FACILITIES

All measurement facilities used to collect the measurement data are located at CCSrf Taiwan Xindian Lab. at No.163-1, Jhongsheng Rd., Xindian Dist., New Taipei City, 23151 Taiwan.

The sites are constructed in conformance with the requirements of ANSI C63.4 and CISPR Publication 22. All receiving equipment conforms to CISPR 16-1-1, CISPR 16-1-2, CISPR 16-1-3, CISPR 16-1-4 and CISPR 16-1-5.

## 6.2. ACCREDITATIONS

Our laboratories are accredited and approved by the following accreditation body according to ISO/IEC 17025.

Taiwan	TAF
USA	A2LA

The measuring facility of laboratories has been authorized or registered by the following approval agencies.

Canada	Industry Canada
Norway	Nemko
Japan	VCCI
Taiwan	BSMI
USA	FCC

Copies of granted accreditation certificates are available for downloading from our web site, <u>http://www.ccsrf.com</u>

## 6.3. MEASUREMENT UNCERTAINTY

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2:

Measurement	Frequency	Uncertainty
Conducted emissions	0.15MHz ~ 30MHz	± 1.59
Radiated emissions	30MHz ~ 1000MHz	± 4.02
	1000MHz ~ 6000MHz	± 4.74

This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

Consistent with industry standard (e.g. CISPR 22: 2005, clause 11, Measurement Uncertainty) determining compliance with the limits shall be base on the results of the compliance measurement. Consequently the measure emissions being less than the maximum allowed emission result in this be a compliant test or passing test.

The acceptable measurement uncertainty value without requiring revision of the compliance statement is base on conducted and radiated emissions being less than  $U_{CISPR}$  which is 3.6dB and 5.2dB respectively. CCS values (called  $U_{Lab}$  in CISPR 16-4-2) is less than  $U_{CISPR}$  as shown in the table above. Therefore, MU need not be considered for compliance.

# 7 EMISSION TEST

## 7.1. CONDUCTED EMISSION MEASUREMENT AT AC MAINS PORT

## 7.1.1. LIMITS

## CLASS A

FREQUENCY	Group 1	≤ 20kV	Group 1 / Group 2		Group 2 > 20kV		
(MHz)	Quasi-peak (dBuV)	Average (dBuV)	Quasi-peak (dBuV)	Average (dBuV)	Quasi-peak (dBuV)	Average (dBuV)	
0.15 - 0.5	79	66	100	90	130	120	
0.50 - 5.0	73	60	86	76	125	115	
			90	80			
5.0 - 30.0	73	60	Decreasing li logarithm of fi		115	105	
			73	60			

**Note:** The lower limit shall apply at the transition frequencies. Care should be taken to comply with leakage current requirements.

### **CLASS B**

FREQUENCY	Group	01&2
(MHz)	Quasi-peak (dBuV)	Average (dBuV)
0.15 - 0.5	66 Decreasing linearly with logarithm of frequency to 56	56 Decreasing linearly with logarithm of frequency to 46
0.50 - 5.0	56	46
5.0 - 30.0	60	50

**Note:** The lower limit shall apply at the transition frequencies. Care should be taken to comply with leakage current requirements.

## 7.1.2. TEST INSTRUMENTS

	Conducted Emission room # A								
Name of Equipment	Manufacturer	Model	Serial Number	Calibration Due					
BNC CABLE	EMCI	CFD300-NL	BNC#A8	05/19/2016					
EMI Test Receiver	R&S	ESCI	101201	08/21/2016					
LISN	Schwarzbeck	NNLK 8129	8129-286	10/27/2016					
LISN(EUT)	Schwarzbeck	NSLK 8127	8127527	08/23/2016					
Pulse Limiter	R&S	ESH3Z2	C3010026-2	08/23/2016					
Thermo-Hygro Meter	Wisewind	201A	No. 02	05/02/2017					
Test S/W	EZ-EMC								

**NOTE:** 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. N.C.R = No Calibration Request.

## 7.1.3. TEST PROCEDURES (please refer to measurement standard or CCS SOP PA-031)

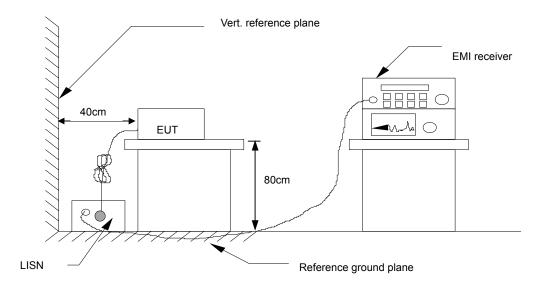
## Procedure of Preliminary Test

- The EUT and Support equipment, if needed, was set up as per the test configuration to simulate typical usage per the user's manual. When the EUT is a tabletop system, a wooden table with a height of 0.8 meters is used and is placed on the ground plane as per EN 55011 (see Test Facility for the dimensions of the ground plane used). When the EUT is a floor standing equipment, it is placed on the ground plane, which has a 15 cm non-conductive covering to insulate the EUT from the ground plane.
- All I/O cables were positioned to simulate typical actual usage as per EN 55011.
- The test equipment EUT installed received AC main power, through a Line Impedance Stabilization Network (LISN), which supplied power source and was grounded to the ground plane.
- All support equipment power received from a second LISN.
- The EUT test program was started. Emissions were measured on each current carrying line of the EUT using an EMI Test Receiver connected to the LISN powering the EUT.
- The Receiver scanned from 150kHz to 30MHz for emissions in each of the test modes.
- During the above scans, the emissions were maximized by cable manipulation.
- The test mode(s) described in Item 4.1 were scanned during the preliminary test.
- After the preliminary scan, we found the test mode described in Item 4.1 producing the highest emission level.
- The EUT configuration and cable configuration of the above highest emission levels were recorded for reference of the final test.

### Procedure of Final Test

- EUT and support equipment were set up on the test bench as per the configuration with highest emission level in the preliminary test.
- A scan was taken on both power lines, Line 1 and Line 2, recording at least the six highest emissions. Emission frequency and amplitude were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit.
- The test data of the worst-case condition(s) was recorded.

## 7.1.4. TEST SETUP



• For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

## 7.1.5. DATA SAMPLE

Freq. (MHz)	Reading (dBuV)	Factor (dB)	Result (dBuV)	Limit (dBuV)	Margin (dB)	Detector (P/Q/A)	Line (L1/L2)
X.XX	42.95	0.55	43.50	73	-29.50	Q	L1
Freq. = Emission frequency in MHz Reading = Uncorrected Analyzer/Receiver reading							

Factor	= Insertion loss of LISN + Cable Loss + Pulse Limit
<b>D</b> 11	

- Result = Read Level + Factor
- Limit = Limit stated in standard
- Margin = Reading in reference to limit
- P = Peak Reading
- Q = Quasi-peak Reading
- A = Average Reading
- L1 = Hot side
- L2 = Neutral side

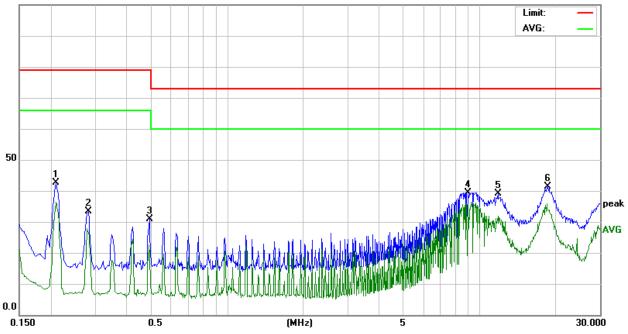
#### **Calculation Formula**

Margin (dB) = Result (dBuV) – Limit (dBuV)

## 7.1.6. TEST RESULTS

Model No.	FWS-7520W3-H25-A10-000	6dB Bandwidth	9 kHz
Environmental Conditions	25°C, 58% RH	Test Mode	Mode 2
Tested by	Stanley Cheng	Phase	L1
Standard	EN 55011 GROUP 1 CLASS A		

100.0 dBuV

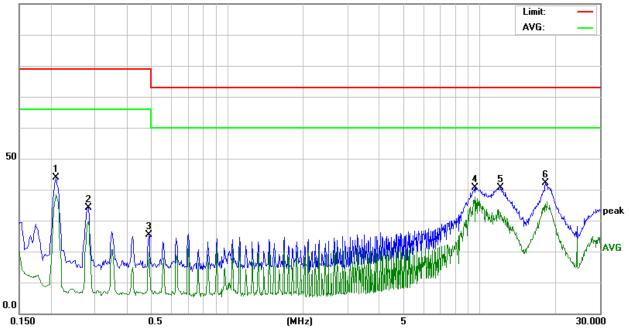


Conducted Emission Readings							
Frequency Range Investigated					150 kHz to	30 MHz	
Freq. (MHz)	Reading (dBuV)	Factor (dB)	Result (dBuV)	Limit (dBuV)	Margin (dB)	Detector (P/Q/A)	Line (L1/L2)
0.2100	32.49	10.07	42.56	79.00	-36.44	Р	L1
0.2819	23.34	10.08	33.42	79.00	-45.58	Р	L1
0.4940	20.72	10.09	30.81	79.00	-48.19	Р	L1
8.9700	28.86	10.53	39.39	73.00	-33.61	Р	L1
11.8500	28.45	10.66	39.11	73.00	-33.89	Р	L1
18.6900	30.46	10.98	41.44	73.00	-31.56	Р	L1

Note: L1 = Line One (Live Line) / L2 = Line Two (Neutral Line).

Model No.	FWS-7520W3-H25-A10-000	6dB Bandwidth	9 kHz
Environmental Conditions	25°C, 58% RH	Test Mode	Mode 2
Tested by	Stanley Cheng	Phase	L2
Standard	EN 55011 GROUP 1 CLASS A		

100.0 dBuV



Conducted Emission Readings							
Frequency Range Investigated					150 kHz to	30 MHz	
Freq. (MHz)	Reading (dBuV)	Factor (dB)	Result (dBuV)	Limit (dBuV)	Margin (dB)	Detector (P/Q/A)	Line (L1/L2)
0.2100	33.79	10.07	43.86	79.00	-35.14	Р	L2
0.2819	24.16	10.08	34.24	79.00	-44.76	Р	L2
0.4900	15.28	10.08	25.36	79.00	-53.64	Р	L2
9.6020	29.99	10.55	40.54	73.00	-32.46	Р	L2
12.1860	29.89	10.66	40.55	73.00	-32.45	Р	L2
18.2979	31.28	10.96	42.24	73.00	-30.76	Р	L2

Note: L1 = Line One (Live Line) / L2 = Line Two (Neutral Line).

## 7.2. RADIATED EMISSION MEASUREMENT

### 7.2.1. LIMITS

#### **Below 1GHz**

		Measured on a test site	
FREQUENCY (MHz)	Group 1, class A ≤ 20kV	Group 1, class A > 20kV	Group 1, class B
()	Quasi-peak (dBuV/m)	Quasi-peak (dBuV/m)	Quasi-peak (dBuV/m)
0.15 - 30	Under consideration	Under consideration	Under consideration
30 - 230	40	50	30
230 - 1000	47	57	37

**Note**: The lower limit shall apply at the transition frequencies.

#### Above 1GHz

Frequency (MHz)	Class A (dBu	ıV/m) (At 3m)	Class B (dBuV/m) (At 3m)		
r requency (wiriz)	Average	Peak	Average	Peak	
1000 ~ 3000	56	76	50	70	
3000 ~ 6000	60	80	54	74	

**Note**: The lower limit shall apply at the transition frequencies.

According to EN 55022: 2010 / AC: 2011 clause 6.2, the measurement frequency range shown in the following table:

Highest frequency generated or used within the EUT or on which the EUT operates or tunes (MHz)	Upper frequency of measurement range (MHz)
Less than 108	1000
108-500	2000
500-1000	5000
Above 1000	5 times of the highest frequency or 6GHz, whichever is less

## 7.3. TEST INSTRUMENTS

	Open	Area Test Site # E		
Name of Equipment	Manufacturer	Model	Serial Number	Calibration Due
Bilog Antenna	ETC	MCTD 2756	BL11M01007	08/03/2016
Cable	EMCI	8Dr	N-Type#E1	03/28/2017
Cable	EMCI	8Dr	N-Type#E2	03/28/2017
EMI Test Receiver	R&S	ESCI	101299	11/24/2016
Pre-Amplifier	HP	8447D	2944A08282	03/28/2017
Thermo-Hygro Meter	Wisewind	N/A	812	07/13/2016
Test S/W		EZ-EM	С	
	Ab	ove 1GHz Used		
Horn Antenna	ETS	3117	139062	10/21/2016
K-Type Cable x 1m (1-40GHz)	Huber+Suhner	SUCOFLEX 102	33106/2	12/15/2016
Microflex Cable x 7m (1-18GHz)	Rosnol	A1K50-EW0630-A1k5 0-7M	151126-1	12/20/2016
Pre-Amplifier	HP	8449B	3008A01266	12/13/2016
Signal Analyzer	Agilent	N9010A	MY53440125	12/13/2016
Thermo-Hygro Meter	Wisewind	201A	No. 02	05/10/2016
Test S/W		EZ-EM	С	

**NOTE:** 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. N.C.R = No Calibration Request.

### 7.3.1. TEST PROCEDURE (please refer to measurement standard or CCS SOP PA-031)

#### Procedure of Preliminary Test

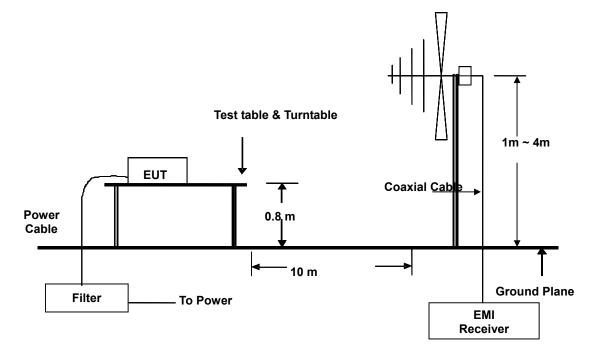
- The equipment was set up as per the test configuration to simulate typical usage per the user's manual. When the EUT is a tabletop system, a wooden turntable with a height of 0.8 meters is used which is placed on the ground plane. When the EUT is a floor standing equipment, it is placed on the ground plane which has a 15 cm non-conductive covering to insulate the EUT from the ground plane.
- Support equipment, if needed, was placed as per EN 55011.
- All I/O cables were positioned to simulate typical usage as per EN 55011.
- The EUT received AC power source from the outlet socket under the turntable. All support equipment power received from another socket under the turntable.
- The antenna was placed at 3 or 10 meter away from the EUT as stated in EN 55011. The antenna connected to the Spectrum Analyzer via a cable and at times a pre-amplifier would be used.
- The Analyzer / Receiver quickly scanned from 30MHz to 6000MHz. The EUT test program was started. Emissions were scanned and measured rotating the EUT to 360 degrees and positioning the antenna 1 to 4 meters above the ground plane, in both the vertical and the horizontal polarization, to maximize the emission reading level.
- The test mode(s) described in Item 4.1 were scanned during the preliminary test:
- After the preliminary scan, we found the test mode described in Item 4.1 producing the highest emission level.
- The EUT and cable configuration, antenna position, polarization and turntable position of the above highest emission level were recorded for the final test.

### Procedure of Final Test

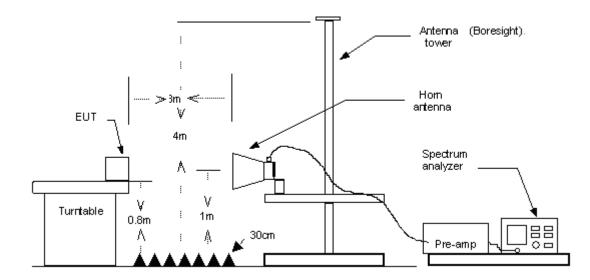
- EUT and support equipment were set up on the turntable as per the configuration with highest emission level in the preliminary test.
- The Analyzer / Receiver scanned from 30MHz to 6000MHz. Emissions were scanned and measured rotating the EUT to 360 degrees, varying cable placement and positioning the antenna 1 to 4 meters above the ground plane, in both the vertical and the horizontal polarization, to maximize the emission reading level.
- Recording at least the six highest emissions. Emission frequency, amplitude, antenna position, polarization and turntable position were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit. Below 1GHz the Q.P. reading and above 1GHz the Peak and Average reading are presented.
- The test data of the worst-case condition(s) was recorded.

## 7.3.2. TEST SETUP

### **Below 1GHz**



### Above 1GHz



• For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

## 7.3.3. DATA SAMPLE

#### Below 1GHz

Freq.	Reading	Factor	Result	Limit	Margin	Detector	Pol.
(MHz)	(dBuV)	(dB/m)	(dBuV/m)	(dBuV/m)	(dB)	(P/Q)	(H/V)
X.XX	14.0	12.2	26.2	40	-13.8	Q	

#### Above 1GHz

Freq.	Reading	Factor	Result	Limit	Margin	Detector	Pol.
(MHz)	(dBuV)	(dB/m)	(dBuV/m)	(dBuV/m)	(dB)	(P/A)	(H/V)
X.XX	42.95	0.55	43.50	60	-16.50	А	

Freq. = Emission frequency in MHz

Reading = Uncorrected Analyzer/Receiver reading

- ctor = Antenna Factor + Cable Loss Amplifier Gain
- Factor = Antenna Factor + C Result = Reading + Factor
- Limit = Limit stated in standard
- Margin = Reading in reference to limit
- P = Peak Reading
- Q = Quasi-peak Reading
- A = Average Reading
- H = Antenna Polarization: Horizontal

V = Antenna Polarization: Vertical

### **Calculation Formula**

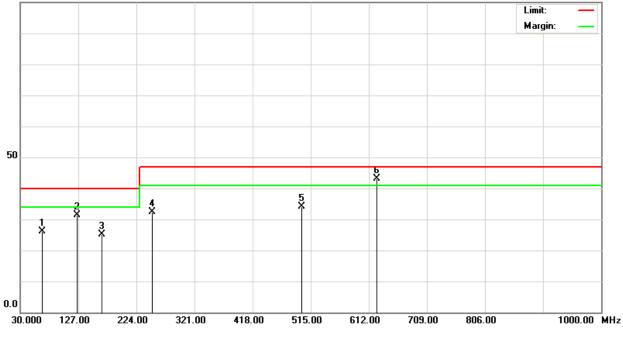
Margin (dB) = Result (dBuV/m) – Limit (dBuV/m)

## 7.3.4. TEST RESULTS

#### **Below 1GHz**

Model No.	FWS-7520W3-H25-A10-000	Test Mode	Mode 1		
Environmental Conditions	22°C, 71% RH	6dB Bandwidth	120 kHz		
Antenna Pole	Vertical	Antenna Distance	10m		
Detector Function	Quasi-peak.	Tested by	Kevin Chang		
Standard	EN 55011 GROUP 1 CLASS A				

100.0 dBuV/m

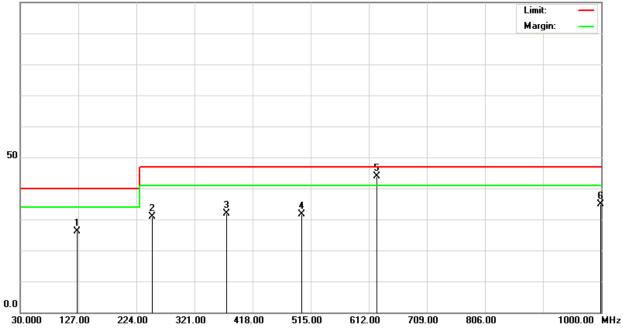


	Radiated Emission Readings											
Fr	Frequency Range Investigated						/Hz to 10	00 MHz a	t 10m			
Freq. (MHz)	Reading (dBuV)	Factor (dB/m)	Result (dBuV/m)	Limit (dBuV/m)		Margin (dB)	Height (cm)	Degree (°)	Detector (P/Q)	Pol. (H/V)		
66.6400	45.40	-19.17	26.23	40	.00	-13.77	100	130	Q	V		
125.0100	44.30	-12.87	31.43	40	.00	-8.57	100	24	Q	V		
166.0300	39.50	-14.25	25.25	40	.00	-14.75	100	120	Q	V		
250.0100	45.90	-13.51	32.39	47	.00	-14.61	100	46	Q	V		
500.1200	41.90	-7.78	34.12	47	.00	-12.88	400	197	Q	V		
624.9900	49.40	-6.15	43.25	47	.00	-3.75	400	203	Q	V		



Model No.	FWS-7520W3-H25-A10-000	Test Mode	Mode 1
Environmental Conditions	22°C, 71% RH	6dB Bandwidth	120 kHz
Antenna Pole	Horizontal	Antenna Distance	10m
Detector Function	Quasi-peak.	Tested by	Kevin Chang
Standard	EN 55011 GROUP 1 CLASS A		

100.0 dBuV/m



	Radiated Emission Readings											
Fr	Frequency Range Investigated						/IHz to 10	00 MHz a	t 10m			
Freq. (MHz)	Reading (dBuV)	Factor (dB/m)	Result (dBuV/m)	Limit (dBuV/m)		Margin (dB)	Height (cm)	Degree (°)	Detector (P/Q)	Pol. (H/V)		
125.0200	39.00	-12.87	26.13	40	.00	-13.87	400	25	Q	Н		
250.0000	44.40	-13.52	30.88	47.	.00	-16.12	400	150	Q	Н		
375.0100	42.20	-10.34	31.86	47.	.00	-15.14	400	130	Q	Н		
500.0200	39.40	-7.78	31.62	47.	.00	-15.38	100	94	Q	Н		
624.9900	50.00	-6.15	43.85	47.	.00	-3.15	100	22	Q	Н		
999.9800	35.20	-0.43	34.77	47.	.00	-12.23	100	34	Q	Н		

Note: P= Peak Reading; Q= Quasi-peak Reading.

## Above 1GHz

Model No.	FWS-7520W3-H25-A10-000	Test Mode	Mode 1		
Environmental Conditions	23°C, 57% RH	6dB Bandwidth	1 MHz		
Antenna Pole	Vertical / Horizontal	Antenna Distance	3m		
Highest frequency generated or used	2000MHz	Upper frequency	6000MHz		
Detector Function	Peak and average.	Tested by	David Cheng		
Standard	Above 1GHz test is Applicable EN 55022 standard.				

	Radiated Emission Readings											
Freque	ency Range	e Investigat	ed		A	bove 1GHz	at 3m					
Freq. (MHz)	Reading (dBuV)	Factor (dB/m)	Result (dBuV/m)		Limit (dBuV/m)	Margin (dB)	Detector (P/A)	Pol. (H/V)				
1250.000	57.18	-8.34	48.84	1	76.00	-27.16	Р	V				
1375.000	52.77	-8.01	44.76	5	76.00	-31.24	Р	V				
1650.000	53.93	-6.36	47.57	7	76.00	-28.43	Р	V				
1933.333	53.48	-3.88	49.60	)	76.00	-26.40	Р	V				
2716.667	50.24	-2.36	47.88	3	76.00	-28.12	Р	V				
2858.333	50.14	-2.16	47.98	3	76.00	-28.02	Р	V				

Radiated Emission Readings								
Freque	ency Range	e Investigat	ed		Α	bove 1GHz	at 3m	
Freq. (MHz)	Reading (dBuV)	Factor (dB/m)	Resul (dBuV/r	-	Limit (dBuV/m)	Margin (dB)	Detector (P/A)	Pol. (H/V)
1125.000	53.52	-8.69	44.83	3	76.00	-31.17	Р	Н
1583.333	54.05	-6.95	47.10	)	76.00	-28.90	Р	Н
1808.333	52.39	-4.97	47.42	2	76.00	-28.58	Р	Н
2500.000	49.17	-2.66	46.51	l	76.00	-29.49	Р	Н
2625.000	51.99	-2.50	49.49	)	76.00	-26.51	Р	Н
2791.667	49.25	-2.25	47.00	)	76.00	-29.00	Р	Н

**Note:** P= Peak Reading; A= Average Reading.

## 7.4. HARMONICS CURRENT MEASUREMENT

## 7.4.1. LIMITS OF HARMONICS CURRENT MEASUREMENT

Limits for Class A equipment			Limits for Class D equipment				
Harmonics Order n	Max. permissible harmonics current A	Harmonics Order n	Max. permissible harmonics current per watt mA/W	Max. permissible harmonics current A			
Od	ld harmonics		Odd Harmonics only	(			
3	2.30	3	3.4	2.30			
5	1.14	5	1.9	1.14			
7	0.77	7	1.0	0.77			
9	0.40	9	0.5	0.40			
11	0.33	11	0.35	0.33			
13	0.21	13	0.30	0.21			
15<=n<=39	0.15x15/n	15<=n<=39	3.85/n	0.15x15/n			
Eve	en harmonics						
2	1.08						
4	0.43						
6	0.30						
8<=n<=40	0.23x8/n						

NOTE: 1. Class A and Class D are classified according to item 7.4.3.

2. According to section 7 of EN 61000-3-2, the above limits for all equipment except for lighting equipment having an active input power > 75 W and no limits apply for equipment with an active input power up to and including 75 W.

## 7.4.2. TEST INSTRUMENTS

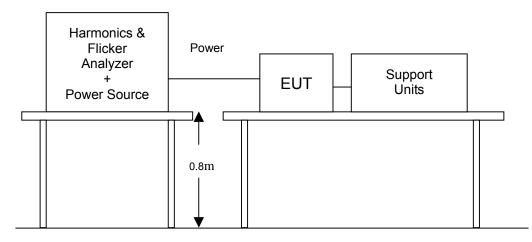
Name of Equipment	Manufacturer	Model	Serial Number	Calibration Due
5kVA Power Source	Teseq	5001IX-208-TSQ	1537A01296	11/10/2016
H/F Measurement System	EMC Partner	HAR1000-1P	189	11/10/2016
Software	HARCS V4.19			

**NOTE:** The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

7.4.3. TEST PROCEDURE (please refer to measurement standard or CCS SOP PA-029)

- The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the maximum harmonic components under normal operating conditions for each successive harmonic component in turn.
- The classification of EUT is according to section 5 of EN 61000-3-2.
- The EUT is classified as follows:
  - Class A: Balanced three-phase equipment, Household appliances excluding equipment as Class D, Tools excluding portable tools, Dimmers for incandescent lamps, audio equipment, equipment not specified in one of the three other classes.
  - Class B: Portable tools; Arc welding equipment which is not professional equipment.
  - Class C: Lighting equipment.
  - Class D: Equipment having a specified power less than or equal to 600 W of the following types: Personal computers and personal computer monitors; television receivers and refrigerators and freezers having one or more variable-speed drives to control compressor motor(s).
- The correspondent test program of test instrument to measure the current harmonics emanated from EUT is chosen. The measure time shall be not less than the time necessary for the EUT to be exercised.

## 7.4.4. TEST SETUP



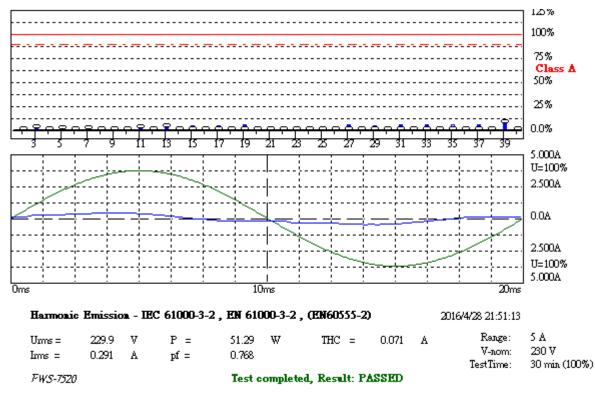
 For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

## 7.4.5. TEST RESULTS

Power Consumption	51.29W	Test Results	PASS
Environmental Conditions	20°C, 56% RH, 1009mbar	Limits	Class 🛛 A 🗆 B 🗆 C 🗆 D
Test Mode	Operating	Tested by	David Cheng

**NOTE:** Limits classified according to item 7.4.1.

## Test result of EN 61000-3-2



HAR-1000 PMC-Partner

Urms = Irms = P = THDi =	229.9V 0.291A 51.29W 25.3 %	Freq = lpk = S = THDu =	50.000 0.486A 66.80VA 0.10 %	Range: cf = pf = Class A	5 A 1.672 0.768					
Test - Time	e : 30min	( 100 %)								
Test completed, Result: PASSED										
Order 1 2	Freq. [Hz] 50 100	lavg [A] 0.2783 0.0000	Irms [A] 0.2817 0.0018	Irms% [%] 96.954 0.6303	Irms%L [%] 0.1695	lmax [A] 0.2972 0.0031	lmax% [%] 102.31 1.0504	lmax%L [%] 0.2826	Limit [A] 1.0800	Status
3	150	0.0666	0.0665	22.899	2.8925	0.0681	23.424	2.9589	2.3000	
4	200	0.0000	0.0003	0.1050	0.0710	0.0006	0.2101	0.1419	0.4300	
5	250	0.0158	0.0156	5.3571	1.3653	0.0177	6.0924	1.5526	1.1400	
6	300	0.0000	0.0003	0.1050	0.1017	0.0006	0.2101	0.2035	0.3000	
7	350	0.0102	0.0101	3.4664	1.3079	0.0122	4.2017	1.5853	0.7700	
8	400	0.0000	0.0003	0.1050	0.1327	0.0003	0.1050	0.1327	0.2300	
9	450	0.0049	0.0049	1.6807	1.2207	0.0067	2.3109	1.6785	0.4000	
5 10 11 12	430 500 550 600	0.00049 0.0000 0.0076 0.0000	0.0003 0.0076 0.0003	0.1050 2.6261 0.1050	0.1659 2.3119 0.1990	0.0006 0.0092 0.0006	0.2101 3.1513 0.2101	0.3317 2.7743 0.3981	0.4000 0.1840 0.3300 0.1533	
13	650	0.0065	0.0064	2.2059	3.0518	0.0079	2.7311	3.7784	0.2100	
14	700	0.0000	0.0003	0.1050	0.2322	0.0003	0.1050	0.2322	0.1314	
15	750	0.0000	0.0040	1.3655	2.6449	0.0049	1.6807	3.2552	0.1500	
16	800	0.0000	0.0003	0.1050	0.2654	0.0003	0.1050	0.2654	0.1150	
17	850	0.0000	0.0040	1.3655	2.9975	0.0046	1.5756	3.4587	0.1324	
18	900	0.0000	0.0003	0.1050	0.2985	0.0006	0.2101	0.5971	0.1022	
19	950	0.0001	0.0043	1.4706	3.6079	0.0049	1.6807	4.1233	0.1184	
20	1000	0.0000	0.0003	0.1050	0.3317	0.0003	0.1050	0.3317	0.0920	
21	1050	0.0000	0.0018	0.6303	1.7090	0.0031	1.0504	2.8483	0.1071	
22	1100	0.0000	0.0003	0.1050	0.3649	0.0006	0.2101	0.7298	0.0836	
23	1150	0.0000	0.0006	0.2101	0.6239	0.0021	0.7353	2.1837	0.0978	
24	1200	0.0000	0.0003	0.1050	0.3981	0.0006	0.2101	0.7961	0.0767	
25	1250	0.0000	0.0015	0.5252	1.6954	0.0024	0.8403	2.7127	0.0900	
26	1300	0.0000	0.0003	0.1050	0.4312	0.0006	0.2101	0.8625	0.0708	
27	1350	0.0000	0.0037	1.2605	4.3945	0.0043	1.4706	5.1270	0.0833	
28	1400	0.0000	0.0006	0.2101	0.9288	0.0006	0.2101	0.9288	0.0657	
29	1450	0.0000	0.0021	0.7353	2.7534	0.0027	0.9454	3.5400	0.0776	
30	1500	0.0000	0.0006	0.2101	0.9951	0.0006	0.2101	0.9951	0.0613	
31	1550	0.0000	0.0034	1.1555	4.6251	0.0037	1.2605	5.0456	0.0726	
32	1600	0.0000	0.0006	0.2101	1.0615	0.0006	0.2101	1.0615	0.0575	
33	1650	0.0000	0.0031	1.0504	4.4759	0.0034	1.1555	4.9235	0.0682	
34	1700	0.0000	0.0006	0.2101	1.1278	0.0006	0.2101	1.1278	0.0541	
35	1750	0.0000	0.0009	0.3151	1.4242	0.0024	0.8403	3.7977	0.0643	
36	1800	0.0000	0.0006	0.2101	1.1942	0.0009	0.3151	1.7912	0.0511	
37	1850	0.0000	0.0031	1.0504	5.0184	0.0031	1.0504	5.0184	0.0608	
38	1900	0.0000	0.0006	0.2101	1.2605	0.0009	0.3151	1.8908	0.0484	
39	1950	0.0042	0.0049	1.6807	8.4635	0.0052	1.7857	8.9925	0.0577	
40	2000	0.0000	0.0009	0.3151	1.9903	0.0012	0.4202	2.6537	0.0460	

### **Definitions of Abbreviations**

Urms Irms Ipk	*** *** ***	Actual total Voltage in Volt RMS Actual total Current in Ampere RMS Actual Peak value of the Current in Ampere
cf		Actual Crest Factor (Ipk/Irms)
Р	***	Actual Active Power in Watt
S	***	Actual Apparent Power in VA (Urms*Irms)
pf	***	Actual Power Factor (P/S)
THDi	***	Actual Total Harmonic Current Distortion in %
THDu	***	Actual Total Harmonic Voltage Distortion in %
THC	***	Actual Total Harmonic Current in Ampere
PHC	***	Actual Partial Harmonic Current in Ampere

Individual measurements for 2nd to 40th order:

lavg		Average value of the Individual Harmonic Current in Ampere RMS
Irms	***	Actual Individual Harmonic Current in Ampere RMS
Irms%	***	Actual Individual Harmonic Current
		in percentage of the actual total RMS Current
lrms%L	***	Actual Individual Harmonic Current
		in percentage of the applicable Limit
Imax		Maximum Individual Harmonic Current
		in Ampere RMS
Imax%		Maximum Individual Harmonic Current
		in percentage of the actual total RMS Current
Imax%lin	า	Maximum Individual Harmonic Current
		in percentage of the applicable Limit
Limit Irms	5	Individual Limit (100%) for the selected Class
		in Ampere RMS

## 7.5. VOLTAGE FLUCTUATION AND FLICKER MEASUREMENT

## 7.5.1. LIMITS OF VOLTAGE FLUCTUATION AND FLICKER MEASUREMENT

TEST ITEM	LIMIT	REMARK
P <sub>st</sub>	1.0	P <sub>st</sub> means short-term flicker indicator.
P <sub>lt</sub>	0.65	P <sub>lt</sub> means long-term flicker indicator.
T <sub>dt</sub> (ms)	500	T <sub>dt</sub> means maximum time that dt exceeds 3 %.
d <sub>max</sub> (%)	4%	d <sub>max</sub> means maximum relative voltage change.
dc (%)	3.3%	dc means relative steady-state voltage change

## 7.5.2. TEST INSTRUMENTS

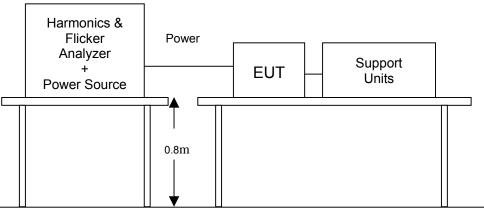
Name of Equipment	Manufacturer	Model	Serial Number	Calibration Due
5kVA Power Source	Teseq	5001IX-208-TSQ	1537A01296	11/10/2016
H/F Measurement System	EMC Partner	HAR1000-1P	189	11/10/2016
Software		HARCS	S V4.19	

**NOTE:** The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

7.5.3. TEST PROCEDURE (please refer to measurement standard or CCS SOP PA-030)

- The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the most unfavorable sequence of voltage changes under normal operating conditions.
- During the flick measurement, the measure time shall include that part of whole operation cycle in which the EUT produce the most unfavorable sequence of voltage changes. The observation period for short-term flicker indicator is 10 minutes and the observation period for long-term flicker indicator is 2 hours.

## 7.5.4. TEST SETUP



• For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

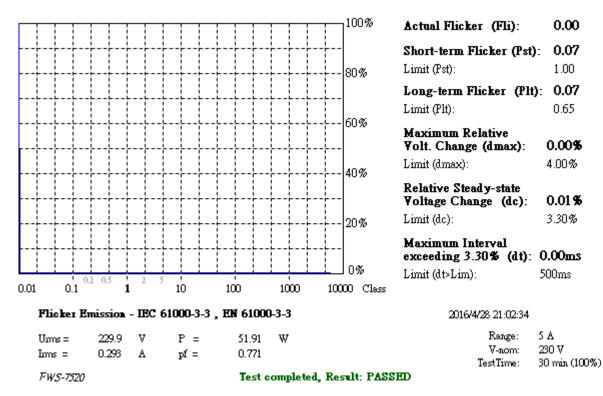
### 7.5.5. TEST RESULTS

Observation Period (Tp)	30mins	Test Mode	Operating
Environmental Conditions	20°C, 56% RH, 1009mbar	Tested by	David Cheng

TEST PARAMETER	MEASUREMENT VALUE	LIMIT	REMARK
P <sub>st</sub>	0.07	1.0	PASS
P <sub>lt</sub>	0.07	0.65	PASS
T <sub>dt</sub> (ms)	0	500	PASS
d <sub>max</sub> (%)	0	4%	PASS
dc (%)	0.01	3.3%	PASS

Note: None.

## Test result of EN 61000-3-3



HAR-1000 EMC-Betuer

# 8 IMMUNITY TEST

## 8.1. GENERAL DESCRIPTION

Product Standard		EN 61000-6-1: 2007
	Test Type	Minimum Requirement
	IEC 61000-4-2	Electrostatic Discharge – ESD: 8kV air discharge, 4kV Contact discharge, Performance Criterion B According to special request by client: 12kV air discharge, 6kV Contact discharge
	IEC 61000-4-3	Radio-Frequency Electromagnetic Field Susceptibility Test – RS: 80 ~ 1000 MHz, 3V/m with 80% AM. 1kHz Modulation 1400 ~ 2000 MHz, 3V/m with 80% AM. 1kHz Modulation 2000 ~ 2700 MHz, 1V/m with 80% AM. 1kHz Modulation Performance Criterion A
	IEC 61000-4-4	Electrical Fast Transient/Burst - EFT, AC Power port: 1kV, DC Power Port: 0.5kV, Signal port: 0.5kV, Performance Criterion B
Basic Standard, Specification, and Performance Criterion required	IEC 61000-4-5	Surge Immunity Test: 1.2/50 µs Open Circuit Voltage, 8 /20 µs Short Circuit Current, AC Power Port ~ line to line: 1kV, line to earth: 2kV DC Power Port ~ line to line and line to earth: 0.5kV Performance Criterion B
	IEC 61000-4-6	Conducted Radio Frequency Disturbances Test – CS: AC Power Port; DC Power Port; Signal Ports and Telecommunication Ports: 0.15 ~ 80MHz, 3Vrms, 80% AM, 1kHz Performance Criterion A
	IEC 61000-4-8	Power frequency magnetic field immunity test 50/60Hz, 3A/m Performance Criterion A
	IEC 61000-4-11	Voltage Dips: i) 0% residual for 0.5 at 50Hz cycle 0% residual for 1 at 50Hz cycle Performance Criterion B ii) 70% residual for 25/30 at 50/60Hz cycles Performance Criterion C Voltage Interruptions: 0% residual for 250/300 at 50/60Hz cycles Performance Criterion C

## **8.2. GENERAL PERFORMANCE CRITERIA DESCRIPTION**

Criteria A:	The apparatus shall continue to operate as intended during and after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, either of these may be derived from the product description and documentation and what the user may reasonably expect from the apparatus if used as intended.
Criteria B:	The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. The performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed. No change of actual operating state or stored data is allowed. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, either of these may be derived from the product description and documentation and what the user may reasonably expect from the apparatus if used as intended.
Criteria C:	Temporary loss of function is allowed, provided the function is self-recoverable or can be restored by the operation of the controls.

## 8.3. ELECTROSTATIC DISCHARGE (ESD)

## 8.3.1. TEST SPECIFICATION

Basic Standard:	IEC 61000-4-2
Discharge Impedance:	330 ohm / 150 pF
Discharge Voltage:	Air Discharge: 2 ; 4 ; 8 ; 12 kV (Direct) Contact Discharge: 2 ; 4 ; 6 kV (Direct/Indirect)
Polarity:	Positive & Negative
Number of Discharge:	Minimum 10 times at each test point
Discharge Mode:	Single Discharge 1 second minimum

### 8.3.2. TEST INSTRUMENT

IMMUNITY SHIELDED ROOM									
Name of Equipment     Manufacturer     Model     Serial Number     Calibration D									
Aneroid Barometer	SATO	7610-20	89090	10/15/2016					
ESD Generator	Teseq	NSG 437	249	12/13/2016					
Thermo-Hygro Meter	Tecpel	DTM-303	80269	04/14/2017					

**NOTE:** The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

## 8.3.3. TEST PROCEDURE (please refer to measurement standard or CCS SOP PA-022)

The discharges shall be applied in two ways:

a) Contact discharges to the conductive surfaces and coupling planes:

The EUT shall be exposed to at least 20 discharges, 10 each at negative and positive polarity, at a minimum of four test points. One of the test points shall be subjected to at least 10 indirect discharges to the center of the front edge of the Horizontal Coupling Plane (HCP). The remaining three test points shall each receive at least 10 direct contact discharges. If no direct contact test points are available, then at least 20 indirect discharges shall be applied in the indirect mode. Test shall be performed at a maximum repetition rate of one discharge per second.

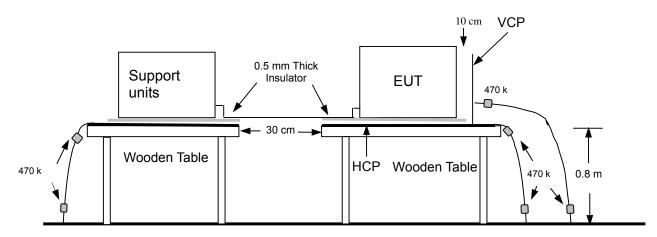
b) Air discharges at slots and apertures and insulating surfaces:

On those parts of the EUT where it is not possible to perform contact discharge testing, the equipment should be investigated to identify user accessible points where breakdown may occur. Such points are tested using the air discharge method. This investigation should be restricted to those area normally handled by the user. A minimum of 10 single air discharges shall be applied to the selected test point for each such area.

The basic test procedure was in accordance with IEC 61000-4-2:

- a) The EUT was located 0.1 m minimum from all side of the HCP (dimensions 1.6m x 0.8m).
- b) The support units were located another table 30 cm away from the EUT, but direct support unit was/were located at same location as EUT on the HCP and keep at a distance of 10 cm with EUT.
- c) The time interval between two successive single discharges was at least 1 second.
- d) Contact discharges were applied to the non-insulating coating, with the pointed tip of the generator penetrating the coating and contacting the conducting substrate.
- e) Air discharges were applied with the round discharge tip of the discharge electrode approaching the EUT as fast as possible (without causing mechanical damage) to touch the EUT. After each discharge, the ESD generator was removed from the EUT and re-triggered for a new single discharge. The test was repeated until all discharges were complete.
- f) At least ten single discharges (in the most sensitive polarity) were applied at the front edge of each HCP opposite the center point of each unit of the EUT and 0.1 meters from the front of the EUT. The long axis of the discharge electrode was in the plane of the HCP and perpendicular to its front edge during the discharge.
- g) At least ten single discharges (in the most sensitive polarity) were applied to the center of one vertical edge of the Vertical Coupling Plane (VCP) in sufficiently different positions that the four faces of the EUT were completely illuminated. The VCP (dimensions 0.5m x 0.5m) was placed vertically to and 0.1 meters from the EUT.

## 8.3.4. TEST SETUP



Ground Reference Plane

• For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

#### NOTE:

#### TABLE-TOP EQUIPMENT

The configuration consisted of a wooden table 0.8 meters high standing on the Ground Reference Plane. The GRP consisted of a sheet of aluminum at least 0.25mm thick, and 2.5 meters square connected to the protective grounding system. A Horizontal Coupling Plane (1.6m x 0.8m) was placed on the table and attached to the GRP by means of a cable with 940k total impedance. The equipment under test, was installed in a representative system as described in section 7 of IEC 61000-4-2, and its cables were placed on the HCP and isolated by an insulating support of 0.5mm thickness. A distance of 1-meter minimum was provided between the EUT and the walls of the laboratory and any other metallic structure.

#### FLOOR-STANDING EQUIPMENT

The equipment under test was installed in a representative system as described in section 7 of IEC 61000-4-2, and its cables were isolated from the Ground Reference Plane by an insulating support of 0.1-meter thickness. The GRP consisted of a sheet of aluminum that is at least 0.25mm thick, and 2.5 meters square connected to the protective grounding system and extended at least 0.5 meters from the EUT on all sides.

## 8.3.5. TEST RESULTS

Temperature	20°C	Humidity	56% RH
Pressure	1009mbar	Tested By	David Cheng
Required Pa	ssing Performance		Criterion B

Air Discharge										
	Test Levels Results									
Test Points	± 2 KV	± 4 KV	± 8 KV	± 12 KV	Pass     Fail     Performance Criterion     Observation					
Front	$\square$	$\boxtimes$	$\square$	$\boxtimes$	$\square$		A B	Note <b>□</b> 1 <b>⊠</b> 2		
Back	$\square$	$\square$	$\square$	$\square$	$\boxtimes$		A B	Note ⊠1  □2		

Contact Discharge								
Test Levels Results							6	
Test Points	± 2 KV	± 4 KV	± 6 KV	Pass	Fail	Performance Criterion	Observation	
Front	$\square$	$\square$	$\square$	$\square$		A DB	Note ⊠1	
Back	$\square$	$\boxtimes$	$\square$	$\square$		A DB	Note ⊠1	
Left	$\square$	$\square$	$\square$	$\square$		A DB	Note ⊠1	
Right	$\boxtimes$	$\square$	$\boxtimes$	$\square$			Note ⊠1	
Тор	$\square$	$\square$	$\square$			A B	Note ⊠1	

Discharge To Horizontal Coupling Plane								
Test Levels Results								
Side of EUT	± 2 kV	± 4 kV	V ± 6 kV Pass Fail Performance Criterion				Observation	
Front	$\square$	$\square$	$\square$	$\square$			Note ⊠1	
Back	$\square$	$\square$	$\square$	$\square$		A DB	Note ⊠1	
Left	$\square$	$\boxtimes$	$\square$	$\square$		⊠A □B	Note ⊠1	
Right	$\square$	$\square$	$\square$	$\square$		A B	Note ⊠1	

Discharge To Vertical Coupling Plane								
Test Levels Results								
Side of EUT	± 2 kV	V ± 4 kV ± 6 kV Pass Fail Performance Criterion Operation				Observation		
Front	$\boxtimes$	$\square$	$\square$	$\square$		A B	Note ⊠1	
Back	$\square$	$\boxtimes$	$\square$	$\boxtimes$		A B	Note ⊠1	
Left	$\square$	$\boxtimes$	$\square$	$\boxtimes$		A B	Note ⊠1	
Right	$\square$	$\square$	$\square$	$\square$		A B	Note ⊠1	

NOTE: 1. There was no change compared with initial operation during the test.

2. No discharge point.



### The Photo for Discharge Points of EUT

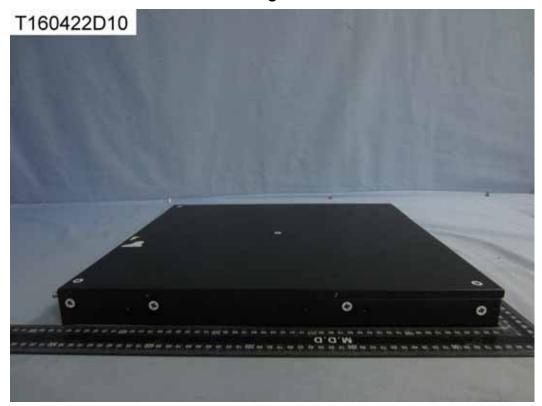




Red Dot —Air Discharged Blue Dot —Contact Discharged



Right



Red Dot —Air Discharged Blue Dot —Contact Discharged Left



Red Dot —Air Discharged Blue Dot —Contact Discharged

## 8.4. RADIATED, RADIO-FREQUENCY, ELECTROMAGNETIC FIELD (RS)

### 8.4.1. TEST SPECIFICATION

Basic Standard:	IEC 61000-4-3
Frequency Range:	80-1000MHz, 1400-2000MHz, 2000-2700MHz
Field Strength:	3V/m, 3V/m, 1V/m
Modulation:	1kHz sine Wave, 80%, AM Modulation.
Frequency Step:	1 % of preceding frequency value
Polarity of Antenna:	Horizontal and Vertical
Test Distance:	3 m
Antenna Height:	1.5 m

### 8.4.2. TEST INSTRUMENT

RS Chamber						
Name of Equipment	Manufacturer	Model	Serial Number	Calibration Due		
Broadband Antenna	AR	AT1080	311819	N.C.R		
Direction Coupler	AR	DC6180A	312189	N.C.R		
Electric Field Probe	AR	FL7006	338955	06/14/2016		
Field of Calibration	CCS	Chamber#RS	80-1000MHz	04/01/2017		
Power Amplifier	AR	500W1000A	320994	N.C.R		
Power Sensor	Boonton	51013-4E	35811	03/09/2017		
Power Sensor	Boonton	51013-4E	35812	03/09/2017		
RF Power Meter	Boonton	4242/1/2	14357	03/09/2017		
Signal Generator	Agilent	N5181A	MY47421336	12/10/2016		
Thermo-Hygro Meter	TFA	N/A	NO.6	10/25/2016		
Calibration of Field	N/A	Chamber#RS	1000-6000MHz	06/21/2016		
Amplifier	AR	50S1G6M1	0343693	No Cal. Required		
Horn Antenna	EMCO	3115	5761	No Cal. Required		
Direction Coupler	AR	DC7200	0343647	No Cal. Required		
Test S/W		Emcware V	/er. 2.6.0.16			

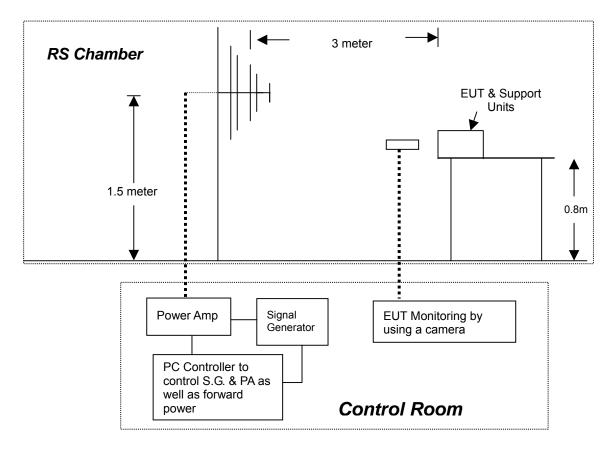
**NOTE:** 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. N.C.R.= No Calibration required.

#### 8.4.3. TEST PROCEDURE (please refer to measurement standard or CCS SOP PA-023)

The test procedure was in accordance with IEC 61000-4-3

- a) The testing was performed in a fully anechoic chamber. The transmit antenna was located at a distance of 3 meters from the EUT.
- b) The frequency range is swept from 80 MHz to 2700 MHz, with the signal 80% amplitude modulated with a 1kHz sine-wave. The rate of sweep did not exceed 1.5 x 10<sup>-3</sup> decade/s, where the frequency range is swept incrementally, the step size was 1% of preceding frequency value.
- c) The dwell time at each frequency shall be not less than the time necessary for the EUT to be able to respond.
- d) The test was performed with the EUT exposed to both vertically and horizontally polarized fields on each of the four sides.



#### 8.4.4. TEST SETUP

 For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

#### NOTE:

#### TABLETOP EQUIPMENT

The EUT installed in a representative system as described in section 7 of IEC 61000-4-3 was placed on a non-conductive table 0.8 meters in height. The system under test was connected to the power and signal wire according to relevant installation instructions.

#### FLOOR STANDING EQUIPMENT

The EUT installed in a representative system as described in section 7 of IEC 61000-4-3 was placed on a non-conductive wood support 0.1 meters in height. The system under test was connected to the power and signal wire according to relevant installation instructions.

#### 8.4.5. TEST RESULTS

Temperature	20°C	Humidity	56% RH
Pressure	1009mbar	Dwell Time	3 sec.
Tested By	David Cheng	Required Passing Performance	Criterion A

Frequency (MHz)	Polarity	Azimuth	Field Strength	Performance Criterion	Observation	Result
80 ~ 1000	V&H	0	3	⊠A ⊡B	Note ⊠1 □2	PASS
80 ~ 1000	V&H	90	3	⊠A □B	Note ⊠1  □2	PASS
80 ~ 1000	V&H	180	3	⊠A □B	Note ⊠1  □2	PASS
80 ~ 1000	V&H	270	3	⊠A □B	Note ⊠1  □2	PASS
1400 ~ 2000	V&H	0	3	⊠A □B	Note ⊠1 □2	PASS
1400 ~ 2000	V&H	90	3	⊠A □B	Note ⊠1 □2	PASS
1400 ~ 2000	V&H	180	3	⊠A □B	Note ⊠1 □2	PASS
1400 ~ 2000	V&H	270	3	⊠A □B	Note ⊠1 □2	PASS
2000 ~ 2700	V&H	0	1	⊠A □B	Note ⊠1 □2	PASS
2000 ~ 2700	V&H	90	1	⊠A □B	Note ⊠1 □2	PASS
2000 ~ 2700	V&H	180	1	⊠A □B	Note ⊠1 □2	PASS
2000 ~ 2700	V&H	270	1	⊠A □B	Note ⊠1 <b>□</b> 2	PASS

NOTE: 1. There was no change compared with the initial operation during the test.

# 8.5. ELECTRICAL FAST TRANSIENT (EFT)

### 8.5.1. TEST SPECIFICATION

Basic Standard:	IEC 61000-4-4
Test Voltage:	Power Line: 1kV Signal Ports and Telecommunication Ports: 0.5kV
Polarity:	Positive & Negative
Impulse Frequency:	5 kHz
Impulse Wave-shape:	5/50 ns
Burst Duration:	15 ms
Burst Period:	300 ms
Test Duration:	Not less than 1 min.

### 8.5.2. TEST INSTRUMENT

Immunity Shield Room						
Name of Equipment Manufacturer Model Serial Number Calibration Due						
Capacitive Clamp	EMC-Partner	CN-EFT1000	589	07/21/2016		
EMC Immunity Tester	EMC Partner	EMC Partner     TRANSINT 2000     1117     03/10/2017				
Software	GenecsVer. 3.27					

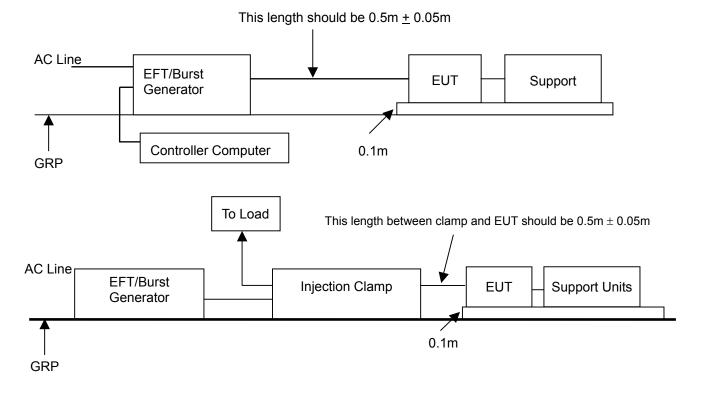
**NOTE:** 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. N.C.R.= No Calibration required.

8.5.3. TEST PROCEDURE (please refer to measurement standard or CCS SOP PA-024)

- a) All types of cables, including their length, and the interface port of the EUT to which they were connected.
- b) Both positive and negative polarity discharges were applied.
- c) The length of the "hot wire" from the coaxial output of the EFT generator to the terminals on the EUT should not exceed 0.5 meter.
- d) The duration time of each test sequential was 1 minute.
- e) The transient/burst waveform was in accordance with IEC 61000-4-4, 5/50ns.

### 8.5.4. TEST SETUP



• For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

#### NOTE:

#### TABLETOP EQUIPMENT

The configuration consisted of a wooden table (0.1m high) standing on the Ground Reference Plane. The GRP consisted of a sheet of aluminum (at least 0.25mm thick and 2.5m square) connected to the protective grounding system. A minimum distance of 0.5m was provided between the EUT and the walls of the laboratory or any other metallic structure.

#### FLOOR STANDING EQUIPMENT

The EUT installed in a representative system as described in section 7 of IEC 61000-4-4 and its cables, were isolated from the Ground Reference Plane by an insulating support that is 0.1-meter thick. The GRP consisted of a sheet of aluminum (at least 0.25mm thick and 2.5m square) connected to the protective grounding system.

### 8.5.5. TEST RESULTS

Temperature	20°C	Humidity	56% RH
Pressure	1009mbar	Tested By	David Cheng
Required P	Required Passing Performance		riterion B

Test Point	Polarity	Test Level (KV)	Performance Criterion	Observation	Result
L	+/-	1	⊠A □B	Note ⊠1	PASS
Ν	+/-	1	⊠A □B	Note ⊠1 <b>□</b> 2	PASS
L - N	+/-	1	⊠A □B	Note ⊠1 <b>□</b> 2	PASS
PE	+/-	1	⊠A □B	Note ⊠1 <b>□</b> 2	PASS
L - PE	+/-	1		Note ⊠1	PASS
N - PE	+/-	1	⊠A □B	Note ⊠1 <b>□</b> 2	PASS
L - N - PE	+/-	1		Note ⊠1	PASS
RJ45	+/-	0.5	⊠A □B	Note ⊠1 <b>□</b> 2	PASS

NOTE: 1. There was no change compared with initial operation during the test.

# 8.6. SURGE IMMUNITY TEST

### 8.6.1. TEST SPECIFICATION

Basic Standard:	IEC 61000-4-5
Wave-Shape:	Combination Wave 1.2/50 µs Open Circuit Voltage 8/20 µs Short Circuit Current
Test Voltage:	AC Power Port ~ line to line: 1kV, line to earth: 2kV
Surge Input/Output:	AC Power Line: L-N / L-PE / N-PE
Generator Source Impedance:	2 ohm between networks 12 ohm between network and ground
Polarity:	Positive/Negative
Phase Angle:	0° / 90° / 180° / 270°
Pulse Repetition Rate:	1 time / min. (maximum)
Number of Tests:	5 positive and 5 negative at selected points

### **8.6.2. TEST INSTRUMENT**

Immunity Shield Room						
Name of Equipment Manufacturer Model Serial Number Calibration Due						
CDN	EMC-Partner	CDN-UTP8	1505	02/22/2017		
EMC Immunity Tester	EMC Partner	EMC Partner     TRANSINT 2000     1117     03/10/2017				
Software	GenecsVer. 3.27					

**NOTE:** 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. N.C.R.= No Calibration required.

#### 8.6.3. TEST PROCEDURE (please refer to measurement standard or CCS SOP PA-025)

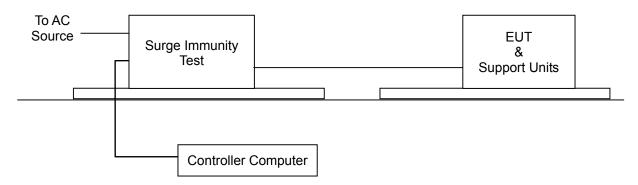
a) For EUT power supply:

The surge is applied to the EUT power supply terminals via the capacitive coupling network. Decoupling networks are required in order to avoid possible adverse effects on equipment not under test that may be powered by the same lines, and to provide sufficient decoupling impedance to the surge wave. The power cord between the EUT and the coupling/decoupling networks was shorter than 2 meters in length.

- b) For test applied to unshielded un-symmetrically operated interconnection lines of EUT: The surge was applied to the lines via the capacitive coupling. The coupling / decoupling networks didn't influence the specified functional conditions of the EUT. The interconnection line between the EUT and the coupling/decoupling networks was shorter than 2 meters in length.
- c) For test applied to unshielded symmetrically operated interconnection / telecommunication lines of EUT:

The surge was applied to the lines via gas arrestors coupling. Test levels below the ignition point of the coupling arrestor were not specified. The interconnection line between the EUT and the coupling/decoupling networks was shorter than 2 meters in length.

#### 8.6.4. TEST SETUP



 For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

### 8.6.5. TEST RESULTS

### Power Supply: FSP / FSP180-50LG

Temperature	20°C	Humidity	56% RH
Pressure	1009mbar	Tested By	David Cheng
Required Passing Performance		Criterion B	

Test Point	Polarity	Test Level (KV)	Performance Criterion	Observation	Result
L - N	+/-	1	⊠A □B	Note ⊠1	PASS
L - PE	+/-	2		Note ⊠1	PASS
N - PE	+/-	2	⊠A □B	Note ⊠1	PASS

NOTE: 1. There was no change compared with initial operation during the test.

#### Power Supply: ETASIS / EFAP-S250

Temperature	19°C	Humidity	58% RH
Pressure	1009mbar	Tested By	Stanley Cheng
Required Passing Performance		Criterion B	

Test Point	Polarity	Test Level (KV)	Performance Criterion	Observation	Result
L - N	+/-	1	⊠A □B	Note ⊠1	PASS
L - PE	+/-	2	⊠A □B	Note ⊠1	PASS
N - PE	+/-	2	A B	Note ⊠1	PASS

NOTE: 1. There was no change compared with initial operation during the test.

# 8.7. CONDUCTED RADIO FREQUENCY DISTURBANCES (CS)

### 8.7.1. TEST SPECIFICATION

Basic Standard:	IEC 61000-4-6
Frequency Range:	0.15 MHz - 80 MHz
Field Strength:	3 Vrms
Modulation:	1kHz Sine Wave, 80%, AM Modulation
Frequency Step:	1 % of preceding frequency value
Coupled cable:	Power Mains, Unshielded; RJ45 Line, Unshielded
Coupling device:	CDN-M3 (3 wires); CDN-T8

### 8.7.2. TEST INSTRUMENT

CS Room						
Name of Equipment	Manufacturer	Model	Serial Number	Calibration Due		
Attenuator	EMCI	SA3NL	10006F	N.C.R		
CDN	Teseq	CDN M016	35820	02/22/2017		
CDN	Teseq	CDN M016	35821	02/22/2017		
CDN	Teseq	CDN T400A	25674	01/11/2017		
CDN	Teseq	CDN T8-10	40369	02/22/2017		
Continuous Wave Simulator	EM Test	CWS 500N1.4	P1446143188	02/21/2017		
Software	icd.control Ver. 5.1.9					

**NOTE:** 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. N.C.R.= No Calibration required.

8.7.3. TEST PROCEDURE (please refer to measurement standard or CCS SOP PA-026)

The EUT shall be tested within its intended operating and climatic conditions.

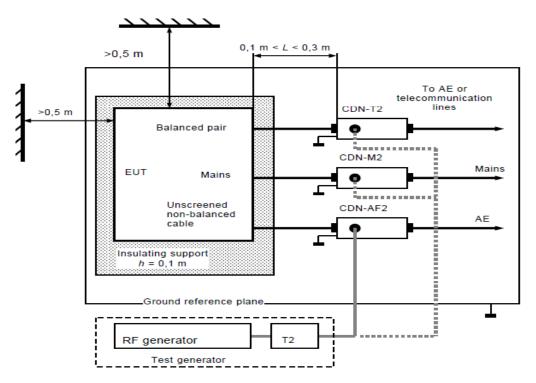
The test shell performed with the test generator connected to each of the coupling and decoupling devices in turn, while the other non-excited RF input ports of the coupling devices are terminated by a 50-ohm load resistor.

The frequency range was swept from 150 kHz to 80MHz, using the signal level established during the setting process and with a disturbance signal of 80 % amplitude. The signal was modulated with a 1 kHz sine wave, pausing to adjust the RF signal level or the switch coupling devices as necessary. The sweep rate was  $1.5 \times 10^{-3}$  decades/s. Where the frequency range is swept incrementally, the step size was 1 % of preceding frequency value from 150 kHz to 80 MHz.

The dwell time at each frequency was less than the time necessary for the EUT to be exercised, and able to respond. Sensitive frequencies such as clock frequency(ies) and harmonics or frequencies of dominant interest, was analyzed separately.

Attempts was made to fully exercise the EUT during testing, and to fully interrogate all exercise modes selected for susceptibility.

### 8.7.4. TEST SETUP



- **Note:** 1. The CDNs and / or EM clamp used for real test depends on ports and cables configuration of EUT. 2. The EUT clearance from any metallic obstacles shall be at least 0.5m
- For the actual test configuration, please refer to the related item Photographs of the Test Configuration.

#### NOTE:

#### TABLE-TOP AND FLOOR-STANDING EQUIPMENT

The equipment to be tested is placed on an insulating support of 0.1 meters height above a ground reference plane. All relevant cables shall be provided with the appropriate coupling and decoupling devices at a distance between 0.1 meters and 0.3 meters from the projected geometry of the EUT on the ground reference plane.

### 8.7.5. TEST RESULTS

Temperature	20°C	Humidity	56% RH
Pressure	1009mbar	Tested By	David Cheng
Required Passing Performance		С	riterion A

Frequency Band (MHz)	Field Strength (Vrms)	Cable	Injection Method		mance erion	Observat	tion	Result
0.15 ~ 80	3	AC Power Line (0.3m)	CDN-M3	A	⊡в	Note 🖂1	<b>2</b>	PASS
0.15 ~ 80	3	RJ45 Line (0.3m)	CDN-T8	A	□в	Note 🖂1	<b>2</b>	PASS

NOTE: 1. There was no change compared with initial operation during the test.

# 8.8. POWER FREQUENCY MAGNETIC FIELD

### 8.8.1. TEST SPECIFICATION

Basic Standard:	IEC 61000-4-8
Frequency Range:	50Hz / 60Hz
Field Strength:	3A/m
Observation Time:	1 minute
Inductance Coil:	Rectangular type, 1mx1m

### 8.8.2. TEST INSTRUMENT

Immunity Shield Room							
Name of Equipment	Manufacturer Model Serial Number Calibration Due						
5kVA Power Source	Teseq	5001IX-208-TSQ	1207A03643	N.C.R			
AC/DC Clamp Meter	Lutron	CM-9930R	I.200121	05/26/2016			
Magnetic Field Coil	Teseq	INA 703 W/ 2141	1976 / 1413	04/21/2017			
Software	Win2120Ver. 5.0						

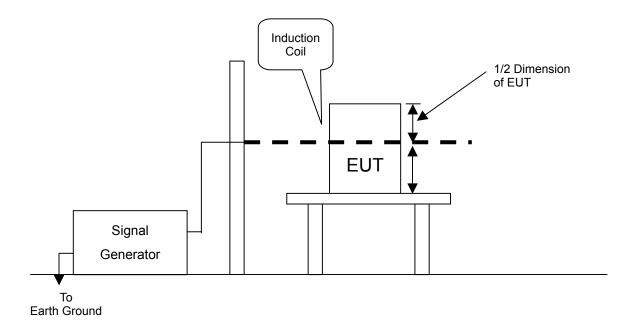
**NOTE:** 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. N.C.R.= No Calibration required.

#### 8.8.3. TEST PROCEDURE (please refer to measurement standard or CCS SOP PA-027)

- a. The equipment is configured and connected to satisfy its functional requirements. It shall be placed on the GRP with the interposition of a 0.1m-thick insulating support.
- b. The equipment cabinets shall be connected to the safety earth directly on the GRP via the earth terminal of the EUT.
- c. The power supply, input and output circuits shall be connected to the sources of power supply, control and signal.
- d. The cables supplied or recommended by the equipment manufacturer shall be used. 1 meter of all cables used shall be exposed to the magnetic field.

### 8.8.4. TEST SETUP



 For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

#### NOTE:

#### TABLETOP EQUIPMENT

The equipment shall be subjected to the test magnetic field by using the induction coil of standard dimension (1 m x 1 m). The induction coil shall then be rotated by 90 degrees in order to expose the EUT to the test field with different orientations.

#### FLOOR-STANDING EQUIPMENT

The equipment shall be subjected to the test magnetic field by using induction coils of suitable dimensions. The test shall be repeated by moving and shifting the induction coils, in order to test the whole volume of the EUT for each orthogonal direction. The test shall be repeated with the coil shifted to different positions along the side of the EUT, in steps corresponding to 50 % of the shortest side of the coil. The induction coil shall then be rotated by 90 degrees in order to expose the EUT to the test field with different orientations.

#### 8.8.5. TEST RESULTS

Temperature	20°C	Humidity	56% RH
Pressure	1009mbar	Tested By	David Cheng
Required Passing Performance		Criterion A	

Direction	Field Strength (A/m)	Performance Criterion	Observation	Results
х	3	А	Note	PASS
Y	3	А	Note	PASS
Z	3	A	Note	PASS

NOTE: There was no change compared with the initial operation during the test.

# 8.9. VOLTAGE DIP & VOLTAGE INTERRUPTIONS

### 8.9.1. TEST SPECIFICATION

Basic Standard:	IEC 61000-4-11
Test duration time:	Minimum three test events in sequence
Interval between event:	Minimum 10 seconds
Phase Angle:	0° / 180°
Test cycle:	3 times

### 8.9.2. TEST INSTRUMENT

Immunity shielded room							
Name of Equipment	Manufacturer     Model     Serial Number     Calibration Due						
AC/DC Clamp Meter	Lutron CM-9930R I.200121 05/26/20						
EMC Immunity Tester	EMC Partner     TRANSINT 2000     1117     03/10/2017						
Software	GenecsVer. 3.27						

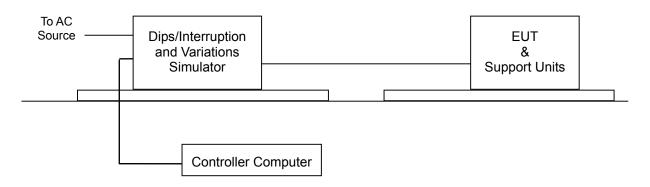
NOTE: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. N.C.R.= No Calibration required.

8.9.3. TEST PROCEDURE (please refer to measurement standard or CCS SOP PA-028)

- 1. The EUT and support units were located on a wooden table, 0.8 m away from ground floor.
- 2. Setting the parameter of tests and then perform the test software of test simulator.
- 3. Conditions changes to occur at 0 degree crossover point of the voltage waveform.
- 4. Recording the test result in test record form.

#### 8.9.4. TEST SETUP



 For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

### 8.9.5. TEST RESULTS

Temperature	20°C	Humidity	56% RH		
Pressure	1009mbar	Tested By	David Cheng		
Required Passing	Criterion B: i) 0% residual 0.5 Cycle at 50Hz 0% residual 1 Cycle at 50Hz Criterion C: ii) 70% residual 25/30 Cycles at 50/60Hz iii) 0% residual for 250/300 Cycles at 50/60Hz				

Test Power: 230Vac, 50Hz						
Voltage (% Residual)	Duration (Cycle)	Performance Criterion	Observation	Test Result		
0	0.5	A B C	Note ⊠1	PASS		
0	1	A B C	Note ⊠1	PASS		
70	25	A B C	Note ⊠1	PASS		
0	250	□A □B ⊠C	Note 🗌 1 🖂 2	PASS		

Test Power: 230Vac, 60Hz						
Voltage (% Residual)	Duration (Cycle)	Performance Criterion	Observation	Test Result		
70	30	A B C	Note ⊠1	PASS		
0	300	□A □B ⊠C	Note <b>□</b> 1 <b>⊠</b> 2	PASS		

**NOTE:** 1. There was no change compared with initial operation during and after the test. No unintentional response was found during the test.

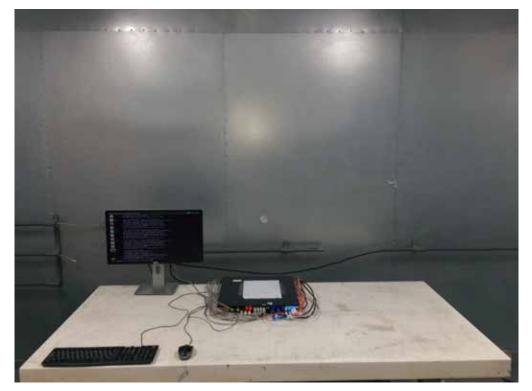
2. EUT shut down, it could not become normal except reinstalled by operator.

# 9 PHOTOGRAPHS OF THE TEST CONFIGURATION CONDUCTED EMISSION TEST





# CONDUCTED EMISSION TEST AT TELECOMMUNICATION PORTS RJ45 Telecom Port with ISN (10Mbps & 100Mbps & 1Gbps)







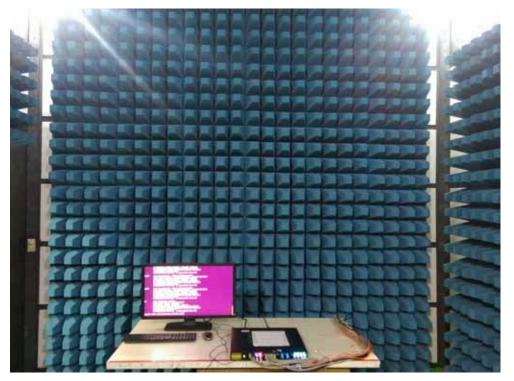




Harmonic & Flicker Test

**ESD** Test



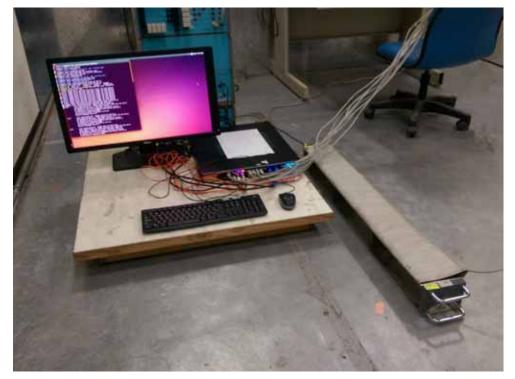


**RS** Test

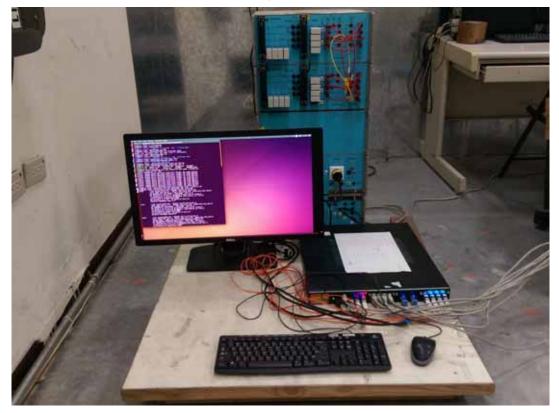
**EFT Test** 



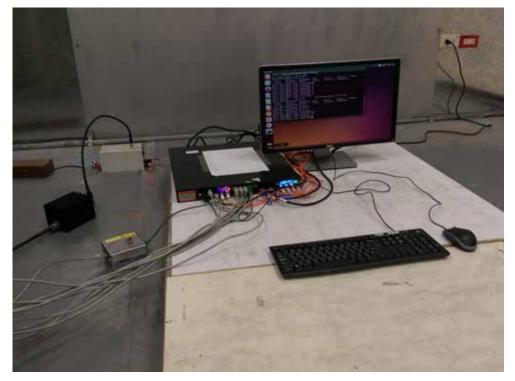
# **EFT For I/O Test**



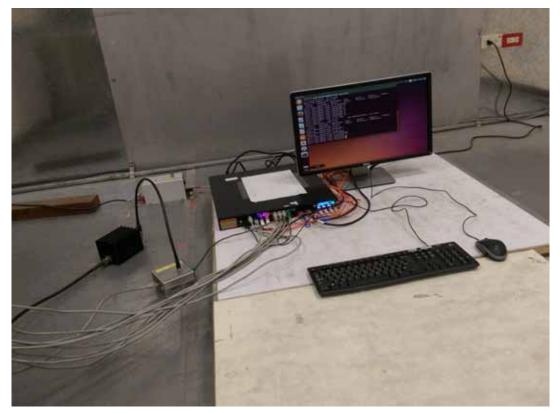
Surge Test

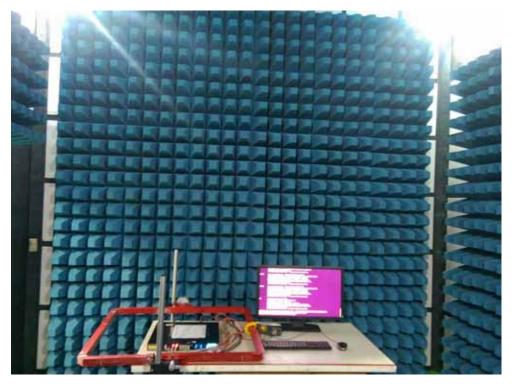


**CS** Test



CS For I/O Test





**PFMF** Test

Voltage Dips / Interruptions Test

